



**PATENT**

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re application of: Wang et al.

Serial No.: 10/672,933

Group Art Unit: 2186

Filed: September 26, 2003

Examiner: TBA

For: APPARATUS AND METHOD FOR  
ANALYZING SAMPLES IN A DUAL  
ION TRAP MASS SPECTROMETER

Atty. Docket No.: 140-099

Honorable Commissioner of Patents and Trademarks  
P.O. Box 1450  
Alexandria, VA 22313-1450

**SUPPLEMENTAL PRELIMINARY AMENDMENT**

S I R:

Prior to substantive review of the subject application, please amend as follows: